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Sheet 1 of 2

Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	Attorney's Docket No. M0023/7000D	Application No. 09/954,515
	Applicant Choi et al.	
	Filing Date September 17, 2001	Group Art Unit

U.S. Patent Documents								
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate	
SH	**AA	4,234,654	11/18/80	Yatabe et al.	428	333		
SH	**AB	4,320,169	03/16/82	Yatabe et al.	428	333		
SH	**AC	4,386,130	05/31/83	Hayashi et al.	428	215		
SH	**AD	4,449,125	05/15/84	Clerc et al.	340	752		
PH	**AE	4,465,736	08/14/84	Nishihara et al.	428	332		
SH	**AF	4,740,782	04/26/88	Aoki et al.	340	719		
SH	**AG	4,815,079	03/21/89	Snitzer et al.	372	6		
SH	**AH	4,931,158	06/05/90	Bunshah et al.	204	192.29		
PH	**AI	5,034,795	07/23/91	Henry	357	30		
PH	**AJ	5,105,291	04/14/92	Matsumoto et al.	204	192.29		
PH	**AK	5,118,538	06/02/92	Escher et al.	428	1		
PH	**AL	5,223,687	06/29/93	Yuasa et al.	219	68		
PH	**AM	5,268,978	12/07/93	Po et al.	385	33		
PH	**AN	5,343,216	08/30/94	Katayama et al.	345	92		
Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
SH	**AO	0 733 931 A	09/25/96	Europe	—	—		✓
SH	**AP	9009730	08/23/90	PCT	—	—		✓
SH	**AQ	09 171 188 A	06/30/97	Japan	—	—	X(Abst.)	
SH	**AR	02 037 326 A	02/07/90	Japan	—	—	X(Abst.)	
SH	**AS	09 152 618 A	10/06/97	Japan	—	—	X(Abst.)	
Other Documents (include Author, Title, Date, and Place of Publication)								
Examiner Initial	Desig. ID	Document						
SH	**AT	Cochrane et al., Proc SPIE, 2017, 68-74 (1993) (Abstract only)						
SH	**AU	Gibbons et al., Soc. Vacuum Coaters 40th Ann. Tech. Conf. Proc., 216-220 (1997)						
SH	**AV	Hara et al., IDW'97, 399-492 (1997)						
SH	**AW	Chu et al., "42.2: A New Conductor Structure for Plastic LCD Applications Utilizing "All Dry" Digital Laser Patterning", 1998 SISD, May 17, 1998, Vol. 29, pp. 1099-1101.						
Examiner Signature		EDW - F. H.			Date Considered 03/20/03			
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

Substitute Disclosure Form (PTO-1449)



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	Applicant Choi et al.	
	Filing Date September 17, 2001	Group Art Unit

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
SH	**BA	5,373,576	12/13/94	Minns et al.	385	125	
SH	**BB	5,418,880	05/23/95	Lewis et al.	385	123	
SH	**BC	5,512,148	04/30/96	Smith, Jr. et al.	204	192.15	
SH	**BD	5,514,618	05/07/96	Hunter, Jr. et al.	437	60	
SH	**BE	5,538,905	07/23/96	Nishioka et al.	204	192.29	
SH	**BF	5,561,440	10/01/96	Kitajima et al.	345	87	
SH	**BG	5,597,626	01/28/97	Eguchi	428	1	12/13/93
SH	BH	5,642,214	06/24/97	Ishii et al.	349	96	07/05/94
SH	**BI	5,652,158	07/29/97	Bae	437	40 TFT	09/05/96
SH	**BJ	5,702,565	12/30/97	Wu et al.	216	65	
SH	**BK	5,726,524	03/10/98	Debe	204	192.1	

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	BL							
	BM							
	BN							
	BO							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
SH	**BP	Patel et al., Soc. Vacuum Coaters 39th Ann. Tech. Conf. Proc., 441-445 (1996)
SH	**BQ	Rottman et al., Proc. SPIE, 2255, 628-638 (1994) (Abstract only)
SH	**BS	International Search Report for PCT/US99/01133 (7/1999)

Examiner Signature <i>SH - F. Hm.</i>	Date Considered <i>03/20/03</i>
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